

Title (en)

PROCESS AND DEVICE FOR TESTING THE PROPERTIES OF AT LEAST ONE SPLICE IN AT LEAST ONE LIGHT GUIDE

Title (de)

VERFAHREN UND EINRICHTUNG ZUR PRÜFUNG DER EIGENSCHAFTEN MINDESTENS EINER SPLEISSSTELLE MINDESTENS EINES LICHTWELLENLEITERS

Title (fr)

PROCEDE ET DISPOSITIF POUR LE CONTROLE DES PROPRIETES D'AU MOINS UNE EPISSURE D'AU MOINS UN GUIDE D'ONDES LUMINEUSES

Publication

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Application

EP 94923662 A 19940819

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Abstract (en)

[origin: US5680206A] PCT No. PCT/DE94/00951 Sec. 371 Date Feb. 29, 1996 Sec. 102(e) Date Feb. 29, 1996 PCT Filed Aug. 19, 1994 PCT Pub. No. WO95/06865 PCT Pub. Date Mar. 9, 1995An optical waveguide splice (SP) is subjected for a prescribable test period to a tensile stress (F), while the light (SL) is launched upstream of the splice (SP) and light (EL) is coupled out downstream of the splice (SP) and the optical power (a) thereof is determined continuously as a function of the tensile stress (F).

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